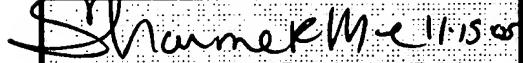


<b>Issue Classification</b>			Application/Control No.		Applicant(s)/Patent under Reexamination	
			10/815,665		LEE, CHANG-HYEON	
Examiner			Art Unit			
Natalia Figueroa			2651			

## ISSUE CLASSIFICATION

ORIGINAL				CROSS REFERENCE(S)						
CLASS	SUBCLASS	CLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
360	53	360	64	31	84	69	75	71		
INTERNATIONAL CLASSIFICATION										
9	1	1	b	5/09						
			/							
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 (Assistant Examiner) <span style="float: right;">11/09/05 (Date)</span>				<b>DAVID HUDSPETH</b> <b>SUPERVISORY PATENT EXAMINER</b> <b>TECHNOLOGY CENTER 2600</b> (Primary Examiner) <span style="float: right;">(Date)</span>					Total Claims Allowed: 13	
 (Legal Instruments Examiner) <span style="float: right;">(Date)</span>									O.G. Print Claim(s)	O.G. Print Fig.
									1	13

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1		31		13	61	91	
2		32		3	62	92	
3		33		6	63	93	
4		34		10	64	94	
5		35			65	95	
6		36			66	96	
7		37			67	97	
8		38			68	98	
9		39			69	99	
10		40			70	100	
11		41			71	101	
12		42			72	102	
13		43			73	103	
14		44			74	104	
15		45			75	105	
16		46			76	106	
17		47			77	107	
18		48			78	108	
19		49			79	109	
20		1	50		80	110	
21			51		81	111	
22		2	52		82	112	
23		4	53		83	113	
24		5	54		84	114	
25		7	55		85	115	
26			56		86	116	
27		8	57		87	117	
28		9	58		88	118	
29		11	59		89	119	
30		12	60		90	120	